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CSD17576Q5B

SLPS497A -JUNE 2014-REVISED MAY 2017

# CSD17576Q5B 30 V N-Channel NexFET™ Power MOSFET

#### 1 Features

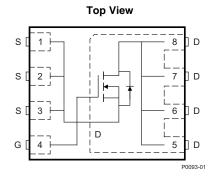
- Low Q<sub>a</sub> and Q<sub>ad</sub>
- Low R<sub>DS(on)</sub>
- Low Thermal Resistance
- Avalanche Rated
- Pb Free Terminal Plating
- **RoHS** Compliant
- Halogen Free
- SON 5-mm × 6-mm Plastic Package

#### Applications 2

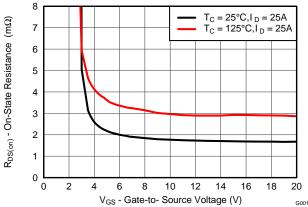
- Point-of-Load Synchronous Buck Converter for Applications in Networking, Telecom, and Computing Systems
- Optimized for Synchronous FET Applications

# 3 Description

This 30 V, 1.7 mΩ, SON 5 x 6-mm NexFET<sup>™</sup> power MOSFET has been designed to minimize losses in power conversion applications.



# R<sub>DS(on)</sub> vs V<sub>GS</sub>



#### **Product Summary**

T <sub>A</sub> = 25°	°C	TYPICAL VA	UNIT		
V <sub>DS</sub>	Drain -to-Source Voltage 30				
Qg	Gate Charge Total (4.5 V)	nC			
Q <sub>gd</sub>	Gate Charge Gate-to-Drain	5.4	nC		
R <sub>DS(op)</sub> Drain to Source On Resistance		V <sub>GS</sub> = 4.5 V 2.4		mΩ	
R <sub>DS(on)</sub>	Drain to Source On Resistance	V <sub>GS</sub> = 10 V 1.7		mΩ	
V <sub>GS(th)</sub>	Threshold Voltage	1.4	V		

#### Ordering Information<sup>(1)</sup>

Device	Qty	Media	Package	Ship	
CSD17576Q5B	2500	13-Inch Reel	SON 5 × 6 mm	Tape and	
CSD17576Q5BT	250	7-Inch Reel	Plastic Package	Reel	

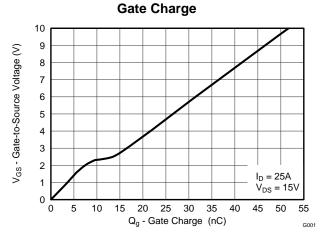
(1) For all available packages, see the orderable addendum at the end of the data sheet.

#### **Absolute Maximum Ratings**

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T <sub>A</sub> = 2	5°C	VALUE	UNIT					
$V_{DS}$	Drain to Source Voltage	30	V					
$V_{GS}$	Gate to Source Voltage	±20	V					
	Continuous Drain Current (Package limited)	100						
I <sub>D</sub>	Continuous Drain Current (Silicon limited), $T_C = 25^{\circ}C$	184	А					
	Continuous Drain Current <sup>(1)</sup>	30						
I <sub>DM</sub>	Pulsed Drain Current, $T_A = 25^{\circ}C^{(2)}$	400	А					
<b>_</b>	Power Dissipation <sup>(1)</sup>	3.1	14/					
PD	Power Dissipation, $T_C = 25^{\circ}C$	125	W					
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction and Storage Temperature Range	-55 to 150	°C					
E <sub>AS</sub>	Avalanche Energy, single pulse $I_D$ = 48, L = 0.1 mH, $R_G$ = 25 $\Omega$	115	mJ					

(1) Typical  $R_{\rm BJA}$  = 40°C/W on a 1-inch², 2-oz. Cu pad on a 0.06-inch thick FR4 PCB.

(2) Max  $R_{\theta,IC}$  = 1.3°C/W, Pulse duration ≤100 µs, duty cycle ≤1%.



An IMPORTANT NOTICE at the end of this data sheet addresses availability, warranty, changes, use in safety-critical applications, intellectual property matters and other important disclaimers. PRODUCTION DATA.

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# **4** Revision History

#### Changes from Original (June 2014) to Revision A

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•	Added the Receiving Notification of Documentation Updates and Community Resources sections to Device and Documentation Support.	7
•	Changed the dimension between pads 3 and 4 from 0.028 inches: to 0.050 inches in the Recommended PCB	
	Pattern section diagram	9

#### EXAS STRUMENTS

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## **5** Specifications

#### 5.1 Electrical Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 

<u> </u>	PARAMETER	TEST CONDITIONS	MIN TYP	MAX	UNIT
STATIC	CHARACTERISTICS		I	ľ	
<b>BV</b> <sub>DSS</sub>	Drain to Source Voltage	$V_{GS} = 0 V, I_D = 250 \mu A$	30		V
I <sub>DSS</sub>	Drain to Source Leakage Current	$V_{GS} = 0 V, V_{DS} = 24 V$		1	μA
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{DS} = 0 V, V_{GS} = 20 V$		100	nA
V <sub>GS(th)</sub>	Gate to Source Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	1.1 1.4	1.8	V
D	Drain to Source On Desistance	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 25 \text{ A}$	2.4	2.9	mΩ
R <sub>DS(on)</sub>	Drain to Source On Resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 25 \text{ A}$	1.7	2.0	mΩ
g <sub>fs</sub>	Transconductance	V <sub>DS</sub> = 3 V, I <sub>D</sub> = 25 A	120		S
DYNAMI	C CHARACTERISTICS				
C <sub>iss</sub>	Input Capacitance		3410	4430	pF
C <sub>oss</sub>	Output Capacitance	$V_{GS} = 0V, V_{DS} = 15 V, f = 1 MHz$	389	506	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		151	196	pF
R <sub>G</sub>	Series Gate Resistance		1.0	2.0	Ω
Qg	Gate Charge Total (4.5 V)		25	32	nC
Qg	Drain to Source Voltage Drain to Source Leakage Current Gate to Source Leakage Current Gate to Source Threshold Voltage Drain to Source On Resistance Transconductance <b>CHARACTERISTICS</b> Input Capacitance Output Capacitance Reverse Transfer Capacitance Series Gate Resistance Gate Charge Total (4.5 V) Gate Charge Total (10 V) Gate Charge Gate to Drain Gate Charge Gate to Source Gate Charge at Vth Output Charge Turn On Delay Time Rise Time Turn Off Delay Time Fall Time		53	68	nC
Q <sub>gd</sub>	Gate Charge Gate to Drain	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 25 A	5.4		nC
Q <sub>gs</sub>	Gate Charge Gate to Source		8.9		nC
Q <sub>g(th)</sub>	Gate Charge at Vth		4.7		nC
Q <sub>oss</sub>	Output Charge	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V	12.3		nC
t <sub>d(on)</sub>	Turn On Delay Time		5		ns
t <sub>r</sub>	Rise Time	V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 10 V,	16		ns
t <sub>d(off)</sub>	Turn Off Delay Time	$I_{DS} = 25 \text{ A}, \text{ R}_{G} = 0 \Omega$	23		ns
t <sub>f</sub>	Fall Time		3		ns
DIODE C	CHARACTERISTICS		· · ·		
$V_{SD}$	Diode Forward Voltage	$I_{SD} = 25 \text{ A}, V_{GS} = 0 \text{V}$	0.8	1	V
Q <sub>rr</sub>	Reverse Recovery Charge	V <sub>DS</sub> = 15 V, I <sub>F</sub> = 25 A,	14.7		nC
t <sub>rr</sub>	Reverse Recovery Time	di/dt = 300 A/µs	14		ns

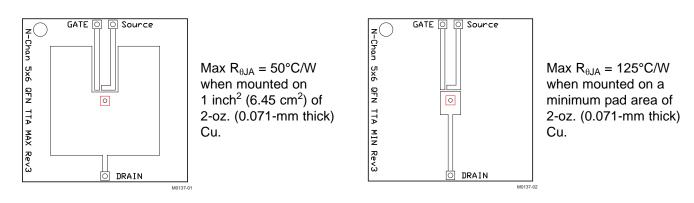
## 5.2 Thermal Information

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 

	THERMAL METRIC	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction-to-Case Thermal Resistance <sup>(1)</sup>			1.3	°C/W
$R_{\thetaJA}$	Junction-to-Ambient Thermal Resistance <sup>(1)(2)</sup>			50	°C/W

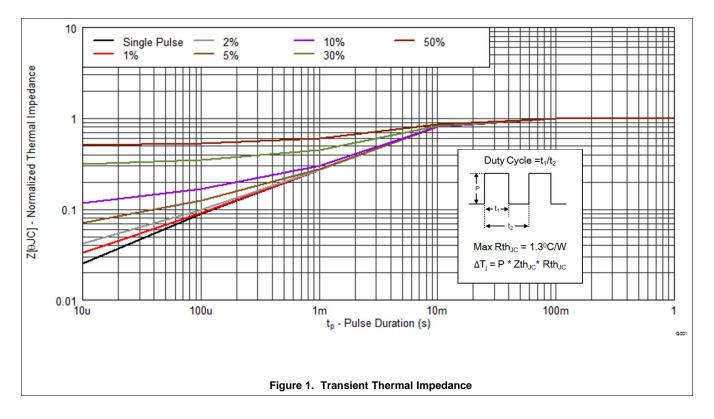
(1) R<sub>θJC</sub> is determined with the device mounted on a 1-inch<sup>2</sup> (6.45-cm<sup>2</sup>), 2-oz. (0.071-mm thick) Cu pad on a 1.5-inches x 1.5-inches (3.81-cm x 3.81-cm), 0.06-inch (1.52-mm) thick FR4 PCB. R<sub>θJC</sub> is specified by design, whereas R<sub>θJA</sub> is determined by the user's board design.
(2) Device mounted on FR4 material with 1-inch<sup>2</sup> (6.45-cm<sup>2</sup>), 2-oz. (0.071-mm thick) Cu.





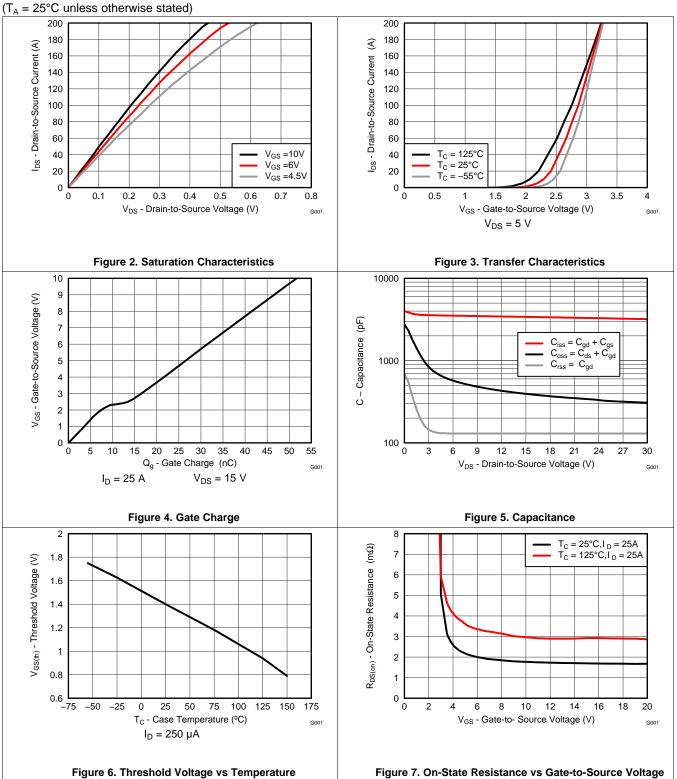
## 5.3 Typical MOSFET Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise stated})$ 



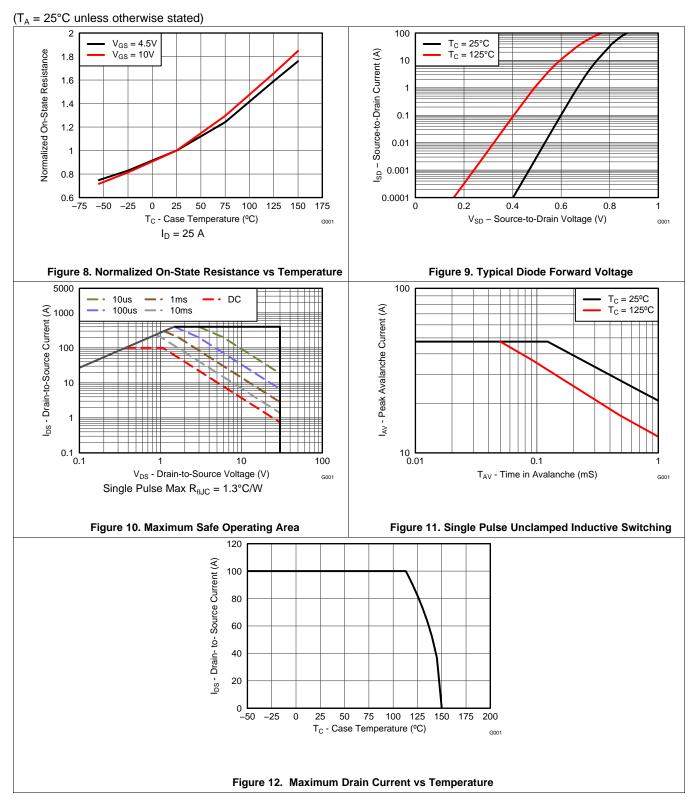


#### **Typical MOSFET Characteristics (continued)**





## **Typical MOSFET Characteristics (continued)**





#### 6 Device and Documentation Support

#### 6.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 6.2 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

TI E2E<sup>™</sup> Online Community *TI's Engineer-to-Engineer (E2E) Community.* Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

**Design Support TI's Design Support** Quickly find helpful E2E forums along with design support tools and contact information for technical support.

#### 6.3 Trademarks

NexFET, E2E are trademarks of Texas Instruments.

#### 6.4 Electrostatic Discharge Caution



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

#### 6.5 Glossary

SLYZ022 — TI Glossary.

This glossary lists and explains terms, acronyms, and definitions.

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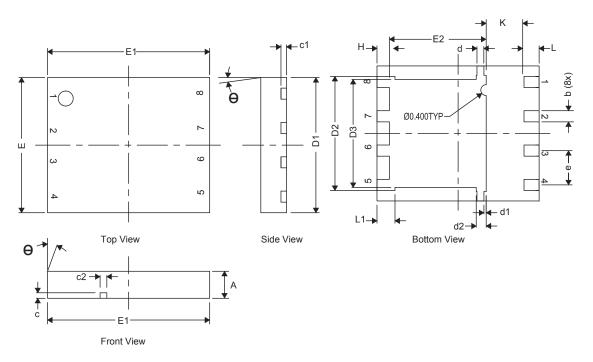


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#### 7 Mechanical, Packaging, and Orderable Information

The following pages include mechanical packaging and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

#### 7.1 Q5B Package Dimensions

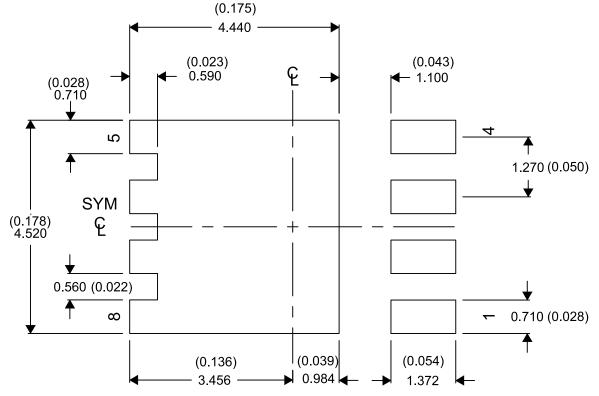


DIM		MILLIMETERS	
DIW	MIN	NOM	MAX
А	0.80	1.00	1.05
b	0.36	0.41	0.46
С	0.15	0.20	0.25
c1	0.15	0.20	0.25
c2	0.20	0.25	0.30
D1	4.90	5.00	5.10
D2	4.12	4.22	4.32
D3	3.90	4.00	4.10
d	0.20	0.30	
d1		0.085 TYP	
d2	0.319	0.369	0.419
E	4.90	5.00	5.10
E1	5.90	6.00	6.10
E2	3.48	3.58	3.68
е		1.27 TYP	
Н	0.36	0.46	0.56
L	0.46	0.56	0.66
L1	0.57	0.67	0.77
θ	0°	-	-
К		1.40 TYP	

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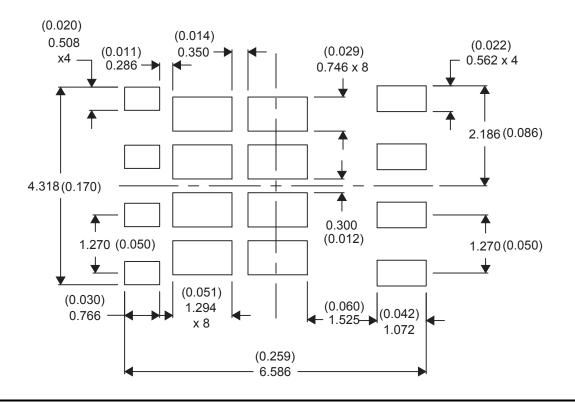


#### 7.2 Recommended PCB Pattern

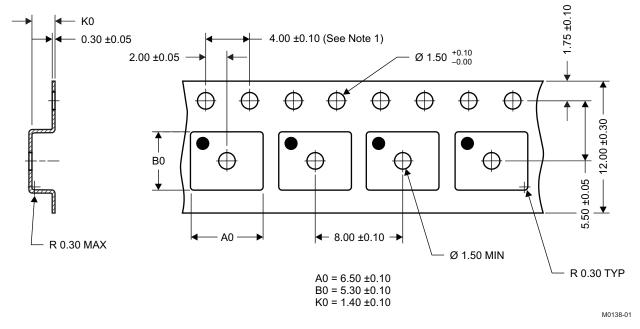


For recommended circuit layout for PCB designs, see application note SLPA005 – Reducing Ringing Through PCB Layout Techniques.

#### 7.3 Recommended Stencil Pattern



## 7.4 Q5B Tape and Reel Information



#### Notes:

- 1. 10-sprocket hole-pitch cumulative tolerance ±0.2.
- 2. Camber not to exceed 1 mm in 100 mm, noncumulative over 250 mm.
- 3. Material: black static-dissipative polystyrene.
- 4. All dimensions are in mm (unless otherwise specified).
- 5. A0 and B0 measured on a plane 0.3 mm above the bottom of the pocket.



9-Jun-2020

# PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
CSD17576Q5B	ACTIVE	VSON-CLIP	DNK	8	2500	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM		CSD17576	Samples
CSD17576Q5BT	ACTIVE	VSON-CLIP	DNK	8	250	Green (RoHS & no Sb/Br)	NIPDAU	Level-1-260C-UNLIM	-55 to 150	CSD17576	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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# PACKAGE OPTION ADDENDUM

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